

Notice of References Cited

Application/Control No.

09/648,896

Applicant(s)/Patent Under

Reexamination

CLELAND ET AL.

Examiner

Christopher H Yaen

Art Unit

1642

Page 1 of 2

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Stancovski et al (PNAS USA 1991 Oct;88(19):8691-8695) ✓
	V	Shepard HM et al (J. Clin. Immunol. 1991 May;11(3):117-127) ✓
	W	Draber et al (J. Immunol Methods 1995 Apr; (181(1):37-43) ✓
	X	Sato et al (Cancer 1992 Nov; 70(10):2493-8) ✓

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited	Application/Control No.	Applicant(s)/Patent Under Reexamination CLELAND ET AL.	
	Examiner Christopher H Yaen	Art Unit 1642	Page 2 of 2

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Nielsen AL et al (Am. J. Clin. Pathol. 1994 Jul;102(1):76-9) ✓
	V	Natali et al (Int. J. Cancer 1990 ;45 457-461)
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.